# MOSFET - Power, N-Channel

# 100 V, 19 A, 74 m $\Omega$

#### **Features**

- Low R<sub>DS(on)</sub>
- High Current Capability
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Para	meter		Symbol	Value	Unit
Fala	Syllibol	value	Oill		
Drain-to-Source Voltage			$V_{DSS}$	100	٧
Gate-to-Source Voltage - Continuous			V <sub>GS</sub>	±20	V
Continuous Drain	Steady	, ,		19	Α
Current	State	T <sub>C</sub> = 100°C	1	13	
Power Dissipation	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	71	W
Pulsed Drain Current	t <sub>p</sub>	= 10 μs	I <sub>DM</sub>	70	Α
Operating and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
Source Current (Body Diode)			Is	19	Α
Single Pulse Drain-to–Source Avalanche Energy ( $V_{DD}$ = 50 Vdc, $V_{GS}$ = 10 Vdc, $I_{L(pk)}$ = 18.2 A, L = 0.3 mH, $R_{G}$ = 25 $\Omega$ )			E <sub>AS</sub>	50	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	47	

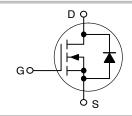
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



## ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
100 V	74 mΩ @ 10 V	19 A



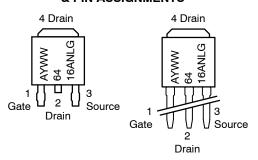


DPAK CASE 369AA STYLE 2



IPAK CASE 369D STYLE 2

# MARKING DIAGRAM & PIN ASSIGNMENTS



A = Assembly Location\*

Y = Year

WW = Work Week
6416ANL = Device Code
G = Pb-Free Package

\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditi	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•		•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 2	250 μΑ	100			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				120		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 100 V	T <sub>J</sub> = 125°C			10	1
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 2)	T.	1				1	_
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 3$	250 μΑ	1.0		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.4		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> =	= 10 A		70	80	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> =	10 A		62	74	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> =	= 19 A		68	74	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 10 A			18		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	ICE					
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			700	1000	pF
Output Capacitance	C <sub>OSS</sub>				110		7
Reverse Transfer Capacitance	C <sub>RSS</sub>				50		1
Total Gate Charge	Q <sub>G(TOT)</sub>				25	40	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>		ļ		0.7		1
Gate-to-Source Charge	$Q_{GS}$	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 80	V, I <sub>D</sub> = 19 A		2.4		1
Gate-to-Drain Charge	$Q_{GD}$				9.6		
Plateau Voltage	$V_{GP}$		Ī		3.2		V
Gate Resistance	$R_{G}$				2.4		Ω
SWITCHING CHARACTERISTICS (No			<u>.</u>		<u>.</u>		
Turn-On Delay Time	t <sub>d(on)</sub>				7.0		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub>	= 80 V.		16		
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 19 A, R <sub>G</sub> =	6.1 Ω		35		
Fall Time	t <sub>f</sub>	1			40		
DRAIN-SOURCE DIODE CHARACTE			<u>.</u>				
Forward Diode Voltage	$V_{SD}$		T <sub>J</sub> = 25°C		0.9	1.2	V
		$V_{GS} = 0 \text{ V}, I_S = 19 \text{ A}$ $T_J = 125^{\circ}\text{C}$			0.72		1
Reverse Recovery Time	t <sub>RR</sub>				50		ns
Charge Time	Ta	Vcs = 0 V dls/dt -	100 A/us		38		1
Discharge Time	T <sub>b</sub>	$V_{GS}$ = 0 V, $dI_S/dt$ = 100 A/ $\mu$ s, $I_S$ = 19 A			14		1
Reverse Recovery Charge	Q <sub>RR</sub>	<b>1</b>			112		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

3. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

ID, DRAIN CURRENT (A)

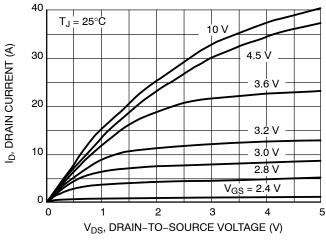


Figure 1. On-Region Characteristics

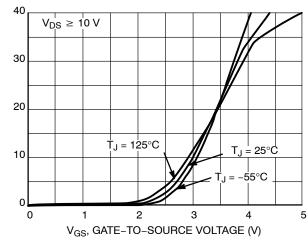


Figure 2. Transfer Characteristics

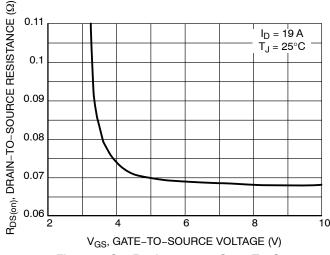


Figure 3. On-Region versus Gate-To-Source Voltage

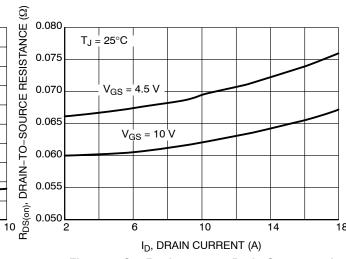


Figure 4. On–Region versus Drain Current and Gate–To–Source Voltage

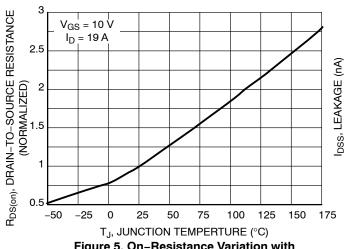


Figure 5. On–Resistance Variation with Temperature

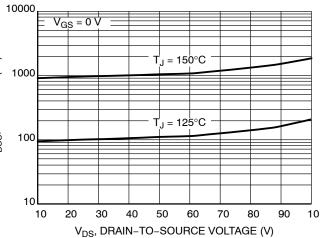
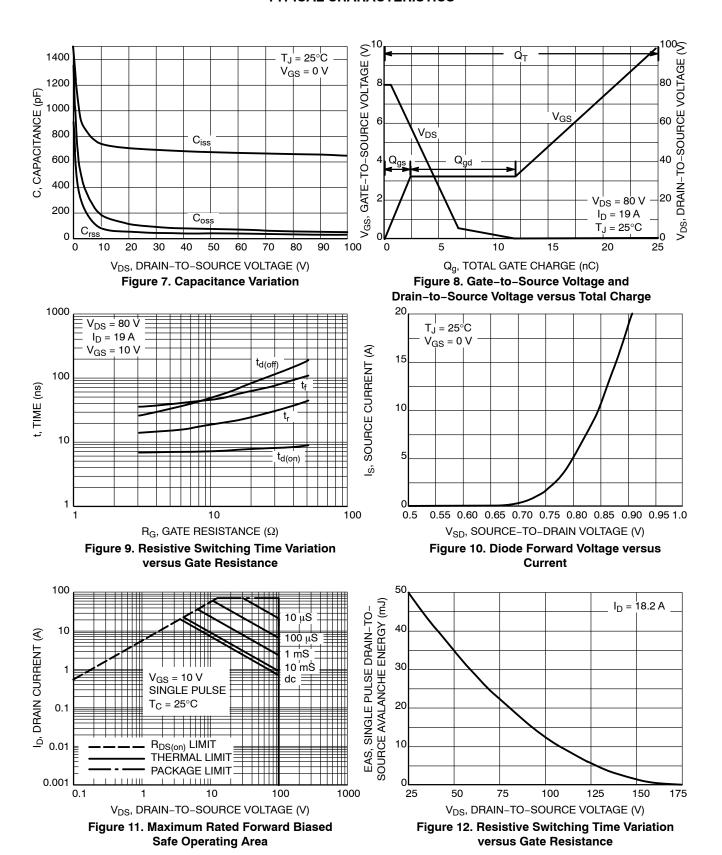


Figure 6. Drian-to-Source Leakage Current versus Voltage

#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**

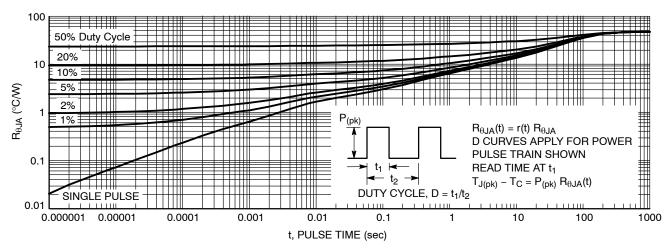


Figure 13. Thermal Response (NTD6416ANL DPAK PCB Cu Area 720 mm<sup>2</sup> PCB Cu thk 2 oz)

#### **ORDERING INFORMATION**

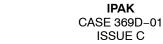
Device	Package	Shipping <sup>†</sup>
NTD6416ANLT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD6416ANL-1G	IPAK (Pb-Free)	75 Units / Rail
NVD6416ANLT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
NVD6416ANLT4G-VF01*	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

<sup>\*</sup>NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

# MECHANICAL CASE OUTLINE





STYLE 3: PIN 1. ANODE

2. CATHODE

4. CATHODE

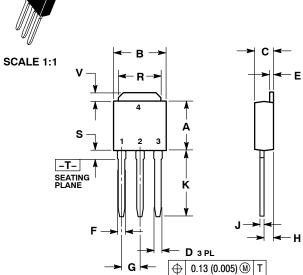
3 ANODE

STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

**DATE 15 DEC 2010** 



STYLE 2:

PIN 1. GATE

3

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. DRAIN

4. DRAIN

MT2

SOURCE

STYLE 1: PIN 1. BASE

3

STYLE 5: PIN 1. GATE

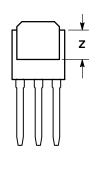
2. ANODE 3. CATHODE

ANODE

2. COLLECTOR

**EMITTER** 

COLLECTOR



#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

#### MARKING DIAGRAMS

STYLE 4:
PIN 1. CATHODE
2. ANODE
3. GATE
4. ANODE
Discrete

XXXXX

ALYWW

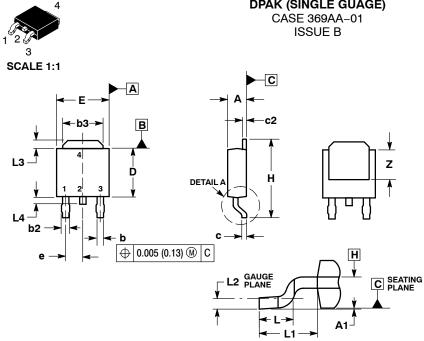
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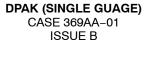
X

xxxxxxxxx = Device Code
A = Assembly Location
IL = Wafer Lot
Y = Year
WW = Work Week

	IPAK (DPAK INSERTION MOUNT)			
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**DETAIL A** ROTATED 90° CW **DATE 03 JUN 2010** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

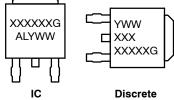
	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

**GENERIC** 

MARKING DIAGRAM\*

#### STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE STYLE 1: PIN 1. BASE STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE 2. COLLECTOR 3. EMITTER 2. CATHODE 3. ANODE 2. DRAIN 3. SOURCE 4. COLLECTOR 4. DRAIN CATHODE STYLE 5: STYLE 6: STYLE 7: PIN 1. GATE 2. ANODE 3. CATHODE PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER 4. ANODE COLLECTOR

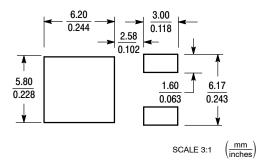
## XXXXXXG



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1

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